

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/809,497 | Applicant(s)/Patent Under Reexamination YAMAMOTO ET AL. | |
| | Examiner Laura A. Bouchelle | Art Unit 3763 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | A | US-2002/0183738 | 12-2002 | Chee et al. | 606/41 |
| | B | US-6,190,360 | 02-2001 | lancea et al. | 604/164.09 |
| | C | US-6,165,164 | 12-2000 | Hill et al. | 604/523 |
| | D | US-2001/0031942 | 10-2001 | Tollner et al. | 604/22 |
| | E | US-2003/0032936 | 02-2003 | Lederman, Robert J. | 604/507 |
| | F | US-6,059,726 | 05-2000 | Lee et al. | 600/439 |
| | G | US-2003/0028172 | 02-2003 | Epstein et al. | 604/507 |
| | H | US-6,086,582 | 07-2000 | Altman et al. | 606/41 |
| | I | US-6,309,370 | 10-2001 | Haim et al. | 604/66 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.